

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/823,981	ALMES ET AL.
	Examiner	Art Unit
	Suchin Parihar	2825

SEARCHED

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST Text Search US-PAT, US-PGPUB, EPO, JPO, DERWENT	8/17/2006	SP
IEEE Xplore Search (See Search History)	8/17/2006	SP
Google Scholar Search http://www.scholar.google.com Keywords: MR, foreground, background, charge-balance, mask, reticle	8/17/2006	SP